Features

- Integrated PLL Loop Filter
- ESD Protection (4kV HBM/200V MM; Except Pin 2: 4kV HBM/100V MM) also at ANT1/ANT2
- High Output Power (8.0dBm) with Low Supply Current (9.0mA)
- Modulation Scheme ASK/FSK
 - FSK Modulation is Achieved by Connecting an Additional Capacitor Between the XTAL Load Capacitor and the Open Drain Output of the Modulating Microcontroller
- . Easy to Design-in Due to Excellent Isolation of the PLL from the PA and Power Supply
- Single Li-cell for Power Supply
- Supply Voltage 2.0V to 4.0V in the Temperature Range of -40°C to +85°C
- Package TSSOP8L
- Single-ended Antenna Output with High Efficient Power Amplifier
- CLK Output for Clocking the Microcontroller
- One-chip Solution with Minimum External Circuitry

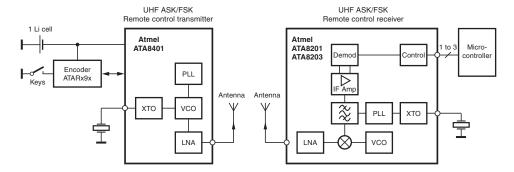
Applications

- Industrial/Aftermarket Remote Keyless Entry Systems
- . Alarm, Telemetering, and Energy Metering Systems
- Remote Control Systems for Consumer and Industrial Markets
- Access Control Systems
- Home Automation
- Home Entertainment
- Toys

1. Description

The Atmel® ATA8401 is a PLL transmitter IC, which has been developed for the demands of RF low-cost transmission systems for industrial applications at data rates up to 50kBaud ASK and 32kBaud FSK modulation scheme. The transmitting frequency range is 300MHz to 350MHz. It can be used in both FSK and ASK systems.

Figure 1-1. System Block Diagram





UHF ASK/FSK Industrial Transmitter

Atmel ATA8401





2. Pin Configuration

Figure 2-1. Pinning TSSOP8L

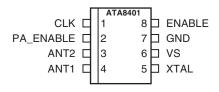


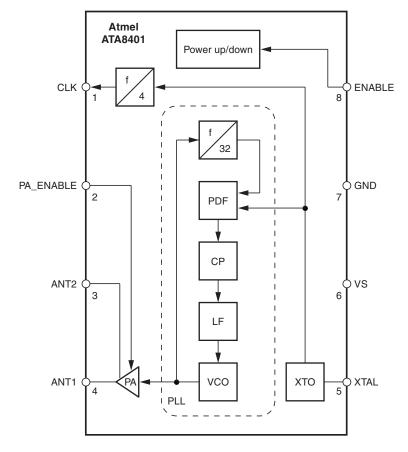
Table 2-1.Pin Description

Pin	Symbol	Function	Configuration
1	CLK	Clock output signal for microcontroller The clock output frequency is set by the crystal to f _{XTAL} /4	100Ω CLK 100Ω
2	PA_ENABLE	Switches on power amplifier used for ASK modulation	PA_ENABLE 50kΩ 20μA
3	ANT2 ANT1	Emitter of antenna output stage Open collector antenna output	ANT1 O ANT2

Table 2-1. Pin Description (Continued)

Pin	Symbol	Function	Configuration
5	XTAL	Connection for crystal	1.5kΩ 1.2kΩ 1.2kΩ 182μA
6	VS	Supply voltage	See ESD protection circuitry (see Figure 4-5 on page 9)
7	GND	Ground	See ESD protection circuitry (see Figure 4-5 on page 9)
8	ENABLE	Enable input	ENABLE 200kΩ O————————————————————————————————————

Figure 2-2. Block Diagram







3. General Description

This fully integrated PLL transmitter allows particularly simple, low-cost RF miniature transmitters to be assembled. The VCO is locked to 32 f_{XTAL}, and therefore a 9.8438MHz crystal is needed for a 315MHz transmitter. All other PLL and VCO peripheral elements are integrated.

The XTO is a series resonance oscillator so that only one capacitor together with a crystal connected in series to GND are needed as external elements.

The crystal oscillator together with the PLL typically needs < 3ms until the PLL is locked and the CLK output is stable. There is a wait time of \ge 3ms until the CLK is used for the microcontroller and the PA is switched on.

The power amplifier is an open-collector output delivering a current pulse, which is nearly independent from the load impedance. The delivered output power is therefore controllable via the connected load impedance.

This output configuration enables a simple matching to any kind of antenna or to 50Ω A high power efficiency of $\eta = P_{out}/(I_{S,PA} \ V_S)$ of 40% for the power amplifier results when an optimized load impedance of $Z_{I,pad} = (255 + j192)\Omega$ is used at 3V supply voltage.

4. Functional Description

If ENABLE = L and the PA_ENABLE = L, the circuit is in standby mode, consuming only a very small amount of current, so that a lithium cell used as power supply can work for several years.

With ENABLE = H the XTO, PLL, and the CLK driver are switched on. If PA_ENABLE remains L, only the PLL and the XTO are running, and the CLK signal is delivered to the microcontroller. The VCO locks to 32 times the XTO frequency.

With ENABLE = H and PA_ENABLE = H the PLL, XTO, CLK driver, and the power amplifier are on. The power amplifier can be switched on and off with PA_ENABLE. This is used to perform the ASK modulation.

4.1 ASK Transmission

The Atmel[®] ATA8401 is activated by ENABLE = H. PA_ENABLE must remain L for typically ≥ 3 ms, then the CLK signal can be taken to clock the microcontroller and the output power can be modulated by means of the PA_ENABLE pin. After transmission, PA_ENABLE is switched to L and the microcontroller switches back to internal clocking. The Atmel ATA8401 is switched back to standby mode with ENABLE = L.

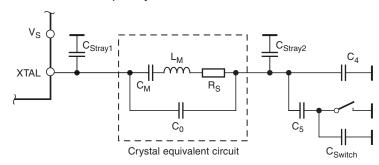
4.2 FSK Transmission

The Atmel ATA8401 is activated by ENABLE = H. PA_ENABLE must remain L for typically \geq 3ms, then the CLK signal can be taken to clock the microcontroller, and the power amplifier is switched on with PA_ENABLE = H. The chip is then ready for FSK modulation. The microcontroller starts to switch on and off the capacitor between the XTAL load capacitor and GND with an open-drain output port, thus changing the reference frequency of the PLL. If the switch is closed, the output frequency is lower than if the switch is open. After transmission, PA_ENABLE is switched to L, and the microcontroller switches back to internal clocking. The Atmel ATA8401 is switched back to standby mode with ENABLE = L.

The accuracy of the frequency deviation with XTAL pulling method is about ±25% when the following tolerances are considered.

4 Atmel ATA8401

Figure 4-1. Tolerances of Frequency Modulation



Using C_4 = 8.2pF ±5%, C_5 = 10pF ±5%, a switch port with C_{Switch} = 3pF ±10%, stray capacitances on each side of the crystal of C_{Stray1} = C_{Stray2} = 1pF ±10%, a parallel capacitance of the crystal of C_0 = 3.2pF ±10%, and a crystal with C_M = 13 fF ±10%, typically results in an FSK deviation of ±21.5kHz with worst case tolerances of ±16.25kHz to ±28.01kHz.

4.3 CLK Output

An output CLK signal is provided for a connected microcontroller. The delivered signal is CMOS compatible if the load capacitance is lower than 10pF.

4.3.1 Clock Pulse Take-over

The clock of the crystal oscillator can be used for clocking the microcontroller. A special feature of Atmel[®]'s AVR[®] is that it starts with an integrated RC-oscillator to switch on the Atmel ATA8401 with ENABLE = H, and after 3ms assumes the clock signal of the transmission IC, so that the message can be sent with crystal accuracy.

4.3.2 Output Matching and Power Setting

The output power is set by the load impedance of the antenna. The maximum output power is achieved with a load impedance of $Z_{Load,opt}$ = (255 + j192) Ω . There must be a low resistive path to V_S to deliver the DC current.

The delivered current pulse of the power amplifier is 9mA. The maximum output power is delivered to a resistive load of 400Ω if the 1.0pF output capacitance of the power amplifier is compensated by the load impedance.

An optimum load impedance of:

 Z_{Load} = 400 Ω || j/(2 × π 1.0pF) = (255 + j192) Ω thus results for the maximum output power of 8 dBm.

The load impedance is defined as the impedance seen from the Atmel ATA8401's ANT1, ANT2 into the matching network. Do not confuse this large signal load impedance with a small signal input impedance delivered as input characteristic of RF amplifiers and measured from the application into the IC instead of from the IC into the application for a power amplifier.

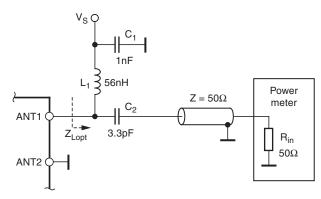
Less output power is achieved by lowering the real parallel part of 400Ω where the parallel imaginary part should be kept constant.

Output power measurement can be done with the circuit shown in Figure 4-2. Note that the component values must be changed to compensate for the individual board parasitics until the Atmel ATA8401 has the right load impedance $Z_{Load,opt} = (255 + j192)\Omega$. Also the damping of the cable used to measure the output power must be calibrated out.





Figure 4-2. Output Power Measurement at f = 315MHz



Note: For 345MHz C₂ has to be changed to 2.7pF

4.4 Application Circuit

A value of C_3 = 68nF/X7R is recommended for the supply-voltage blocking capacitor C_3 (see Figure 4-3 on page 7 and Figure 4-4 on page 8). C_1 and C_2 are used to match the loop antenna to the power amplifier where C_1 typically is 22pF/NP0 and C_2 is 10.8pF/NP0 (18pF + 27pF in series). For C_2 , two capacitors in series should be used to achieve a better tolerance value and to have the possibility of realizing the $Z_{Load,opt}$ using standard valued capacitors.

 C_1 , together with the pins of Atmel[®] ATA8401 and the PCB board wires, forms a series resonance loop that suppresses the 1st harmonic. Therefore, the position of C_1 on the PCB is important. Normally the best suppression is achieved when C_1 is placed as close as possible to the pins ANT1 and ANT2.

The loop antenna should not exceed a width of 1.5mm, otherwise the Q-factor of the loop antenna is too high.

 L_1 ([50nH to 100nH) can be printed on PCB. C_4 should be selected so that the XTO runs on the load resonance frequency of the crystal. Normally, a 15pF load-capacitance crystal results in a value of 12pF.

6

Figure 4-3. ASK Application Circuit

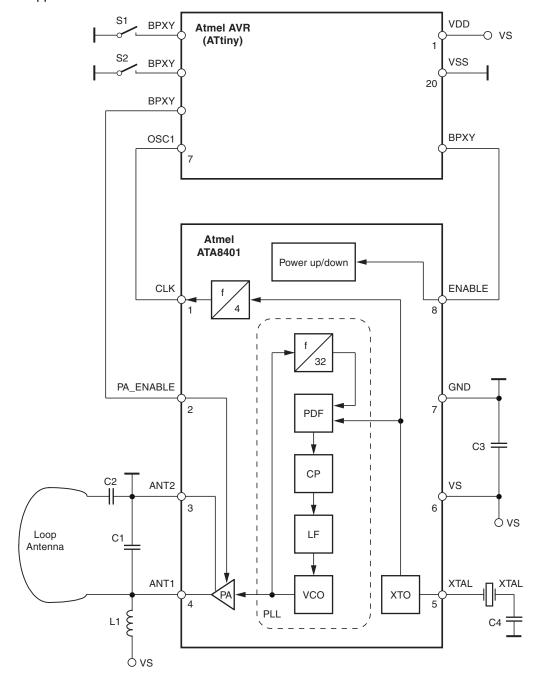




Figure 4-4. FSK Application Circuit

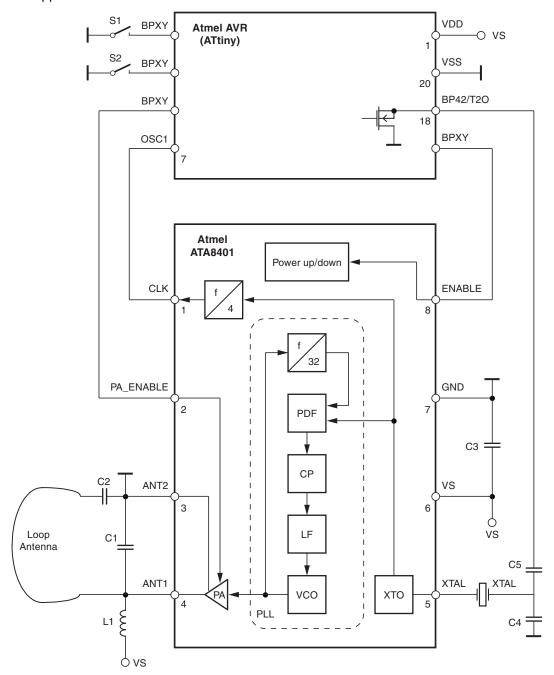
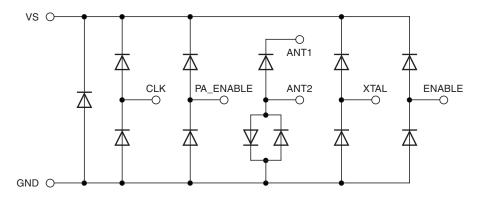


Figure 4-5. **ESD Protection Circuit**



Absolute Maximum Ratings 5.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Parameters	Symbol	Minimum	Maximum	Unit
Supply voltage	V _S		5	V
Power dissipation	P _{tot}		100	mW
Junction temperature	T _j		150	°C
Storage temperature	T _{stg}	– 55	+85	°C
Ambient temperature	T _{amb}	– 55	+85	°C
Input voltage	V _{maxPA_ENABLE}	-0.3	$(V_S + 0.3)^{(1)}$	V

1. If V_S + 0.3 is higher than 3.7V, the maximum voltage will be reduced to 3.7V. Note:

Thermal Resistance 6.

Parameters	Symbol	Value	Unit	
Junction ambient	R _{thJA}	170	K/W	

Electrical Characteristics

 V_S = 2.0V to 4.0V, T_{amb} = 25°C unless otherwise specified. Typical values are given at V_S = 3.0V and T_{amb} = 25°C. All parameters are referred to GND (pin 7).

Parameters Test Conditions		Symbol	Min.	Тур.	Max.	Unit
Supply current	Power down, V _{ENABLE} < 0.25V, -40°C to 85°C V _{PA-ENABLE} < 0.25V, 25°C (100% correlation tested)	I _{S_Off}		< 10	350	nA nA
Supply current	Power up, PA off, $V_S = 3V$, $V_{ENABLE} > 1.7V$, $V_{PA-ENABLE} < 0.25V$	I _S		3.7	4.8	mA
Supply current	Power up, $V_S = 3.0V$, $V_{ENABLE} > 1.7V$, $V_{PA-ENABLE} > 1.7V$	I _{S_Transmit}		9	11.6	mA

Note: 1. If V_S is higher than 3.6V, the maximum voltage will be reduced to 3.6V.





7. Electrical Characteristics (Continued)

 V_S = 2.0V to 4.0V, T_{amb} = 25°C unless otherwise specified. Typical values are given at V_S = 3.0V and T_{amb} = 25°C. All parameters are referred to GND (pin 7).

Parameters	Test Conditions	Symbol	Min.	Тур.	Max.	Unit
Output power	$V_S = 3.0V$, $T_{amb} = 25$ °C, f = 315 MHz, $Z_{Load} = (255 + j192)W$	P_{Ref}	6.0	8.0	10.5	dBm
Output power variation for the full temperature range	$T_{amb} = 25^{\circ}C,$ $V_{S} = 3.0V$ $V_{S} = 2.0V$	$\Delta P_{Ref} \ \Delta P_{Ref}$			-1.5 -4.0	dB dB
Output power variation for the full temperature range	$T_{amb} = 25^{\circ}C,$ $V_{S} = 3.0V$ $V_{S} = 2.0V,$ $P_{Out} = P_{Ref} + \Delta P_{Ref}$	$\Delta P_{Ref} \ \Delta P_{Ref}$			-2.0 -4.5	dB dB
Achievable output-power range	Selectable by load impedance	P _{Out_typ}	0		8.0	dBm
Spurious emission	$f_{CLK} = f_0/128$ Load capacitance at pin CLK = 10pF $f_0 \pm 1 \times f_{CLK}$ $f_0 \pm 4 \times f_{CLK}$ Other spurious are lower			–55 –52		dBc dBc
Oscillator frequency XTO (= phase comparator frequency)	$\begin{split} &f_{XTO} = f_0/32 \\ &f_{XTAL} = \text{resonant frequency of the XTAL,} \\ &C_M \leq 10 \text{fF, load capacitance selected} \\ &\text{accordingly} \\ &T_{amb} = 25^{\circ}\text{C} \end{split}$	f _{XTO}		f _{XTAL}		ppm
PLL loop bandwidth				250		kHz
Phase noise of phase comparator	Referred to $f_{PC} = f_{XTO}$, 25kHz distance to carrier			-116	-110	dBc/Hz
In-loop phase noise PLL	25kHz distance to carrier			-86	-80	dBc/Hz
Phase noise VCO	At 1MHz At 36MHz			-94 -125	-90 -121	dBc/Hz dBc/Hz
Frequency range of VCO		f _{VCO}	300		350	MHz
Clock output frequency (CMOS microcontroller compatible)				f ₀ /128		MHz
Voltage swing at pin CLK	C _{Load} ≤10pF	$V_{0h} V_{0l}$	$V_S \times 0.8$		$V_S \times 0.2$	V V
Series resonance R of the crystal		Rs			110	Ω
Capacitive load at pin XT0					7	pF
FSK modulation frequency rate	Duty cycle of the modulation signal = 50%		0		32	kHz
ASK modulation frequency rate	Duty cycle of the modulation signal = 50%		0		50	kHz
ENABLE input	Low level input voltage High level input voltage Input current high	V _{II} V _{Ih} I _{In}	1.7		0.25 20	V V µA
PA_ENABLE input	Low level input voltage High level input voltage Input current high	V _{II} V _{Ih} I _{In}	1.7		0.25 V _S ⁽¹⁾ 5	V V µA

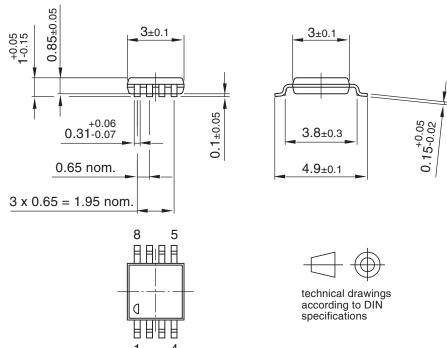
1. If V_S is higher than 3.6V, the maximum voltage will be reduced to 3.6V. Note:

8. Ordering Information

Extended Type Number	Package	MOQ	Remarks
ATA8401-6AQY	TSSOP8L	5000 pcs	Taped and reeled, Pb-free

9. Package Information

Package: TSSOP 8L Dimensions in mm



Drawing-No.: 6.543-5083.01-4

Issue: 2; 15.03.04

10. Revision History

Please note that the following page numbers referred to in this section refer to the specific revision mentioned, not to this document.

Revision No.	History		
4984D-INDCO-12/10	Section 1 "Description" on page 1 changed		
4904D-INDCO-12/10	Section 7 "Electrical Characteristics" on page 10 changed		
	Section 4.3.1 "Clock Pulse Take-over" on page 5 changed		
4984C-INDCO-04/09	Figure 4-3 "ASK Application Circuit" on page 7 changed		
	Figure 4-4 "FSK Application Circuit" on page 8 changed		
4984B-INDCO-11/08	Put datasheet in the newest template		
4904D-INDCO-1 1/00	Section 4.3.1 "Clock Pulse Take-over" on page 5 changed		





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